# Notice of References Cited Application/Control No. 09/900,635 Examiner Nicholas Ponomarenko Applicant(s)/Patent Under Reexamination GILBRETH ET AL. Art Unit Page 1 of 3

### U.S. PATENT DOCUMENTS

	*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	*	Α	US-2,256,938	09-1941	Charbenneaux	290/30R
	*	В	US-2,427,462	09-1947	Kaelin	290/30R
	*	С	US-2,603,756	07-1952	Pottick	290/30R
	*	D	US-2,697,174	12-1954	Stivender	123/198R
Ø	*	Ε	US-2,8,10,079	10-1957	McFeirland	219/133
	*	F	US-2,818,512	12-1957	Mc Farland	290/30R
	*	G	US-2,916,634	12-1959	McFripland	290/30R
	*	н	∮US-3,300,647	01-1967	Crogia et al	290/30R
1	*		US-3,456,120	07-1969	Martin	290/31
	*	K	US-3,526,778	09-1970	Crocker et al	290/30R
	*	к	US-3,678,284	07-1972	Peters, Charles Michael Dansey	290/1R
	*	L	US-4,352,025	09-1982	Troyen, Harry D.	290/54
Į	*	М	US-4,496,845	01-1985	Ensign et al.	290/43

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			170		
	0					
	P					
	Q					
	R					
	S					
	T					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited Application/Control No. 09/900,635 Examiner Nicholas Ponomarenko Applicant(s)/Patent Under Reexamination GILBRETH ET AL. Page 2 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,381,081	01-1995	Radun, Arthur V.	318/696
*	В	US-5,561,330	10-1996	Crook, Gaines M.	290/30R
*	С	US-5,647,317	07-1997	Weisman et al.	123/299
*	D	US-5,886,504	03-1999	Scott et al.	322/15
*	Е	US-6,023,135	02-2000	Gilbreth et al.	290/27
*	F	US-6,031,294	02-2000	Geis et al.	290/40R
*	G	US-6,093,975	07-2000	Peticolas, Brian W.	290/40A
*	Н	US-6,133,643	10-2000	Lukich et al.	290/40A
*	ı	U6-6,169,334	01-2001	Edelman, Edward C.	290/46
*	J	US-6,202,776	03-2001	Masberg et al.	180/65.2
*	к	US-6,265,786	07-2001	Bosley et al.	290/46
*	L	US-6,274,945	08-2001	Gilbreth et al.	290/47
*	М	US-6,281,596	08-2001	Gilbreth et al.	123/3

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited

Application/Control No.

09/900,635

Applicant(s)/Patent Under Reexamination GILBRETH ET AL.

Examiner

Art Unit

Nicholas Ponomarenko

2834

Page 3 of 3

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,281,601	08-2001	Edelman et al.	290/52
*	В	US-6,294,842	09-2001	Skowronski, Mark J.	290/7
*	С	US-6,325,142	12-2001	Bosley et al.	166/53
*	D	US-6,355,987	03-2002	Bixel, Paul S.	290/52
*	Ε	US-6,410,9 <b>9</b> 2	06-2002	Wall et al.	290/52
*	F	US-200/10030425 10-2001	06-2001	Gilbreth et al.	290/52
*	G	US-2001/0052704 (2-200)	04-2001	Bosley et al.	290/52
*	Н	ys-2002/0005643 1-2002	(07-2001°	Gilbreth et al.	290/52
*	1	US-2002/0030364 3.2002	Q4-2001°	Bosley et al.	290/7
*	J	US-2002/0089234	07-2002	Gilbreth et al.	9/04
	к	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>V</b>	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.